



Section 5

Electrical Characteristics

The electrical characteristics of a particular gate array design are determined after evaluation of samples. This section describes the standard characteristics by a series of tables and graphs.

Tables

Exposure to the absolute maximum ratings in table 5-1 for extended periods may affect device reliability; exceeding the ratings could cause permanent damage. The gate array device should not be operated under conditions outside those recommended in table 5-2. The input signal specifications depend on whether the interface is with a CMOS-level or TTL-level device.

Tables 5-3 and 5-4 show dc characteristics and ac characteristics. Some of these signal specifications are dependent on an external CMOS or TTL interface, also. If all input and output signals interface with CMOS-level devices, the supply voltage and ambient temperature limits of the gate array chip are:

$$V_{DD} = 5.0 \text{ volts } \pm 10\%$$

$$T_A = -40 \text{ to } +85^\circ\text{C}$$

If one or more of the signals interface with TTL-level devices:

$$V_{DD} = 5.0 \text{ volts } \pm 5\%$$

$$T_A = -40 \text{ to } +85^\circ\text{C}$$

Table 5-5 lists the maximum internal capacitance that you may expect at the signal ports of the gate array chip.

Table 5-1. Absolute Maximum Ratings

$T_A = +25^\circ\text{C}$

Power supply voltage, V_{DD}	−0.5 to +7.0 V	
Input voltage, V_I	−0.5 V to $V_{DD} + 0.5$ V	
Input current, I_I	40 mA	
Output current, I_O	40 mA	
Operating temperature, T_{OPT}	−40 to +85°C	
Storage temperature, T_{STG}	−65 to +150°C	

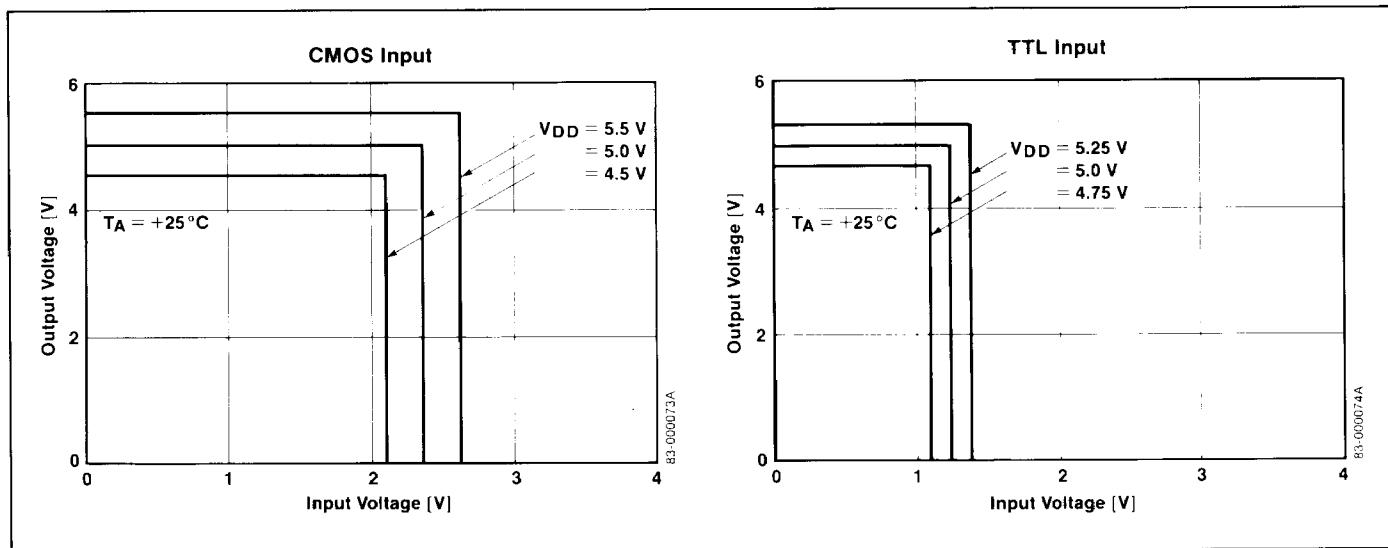
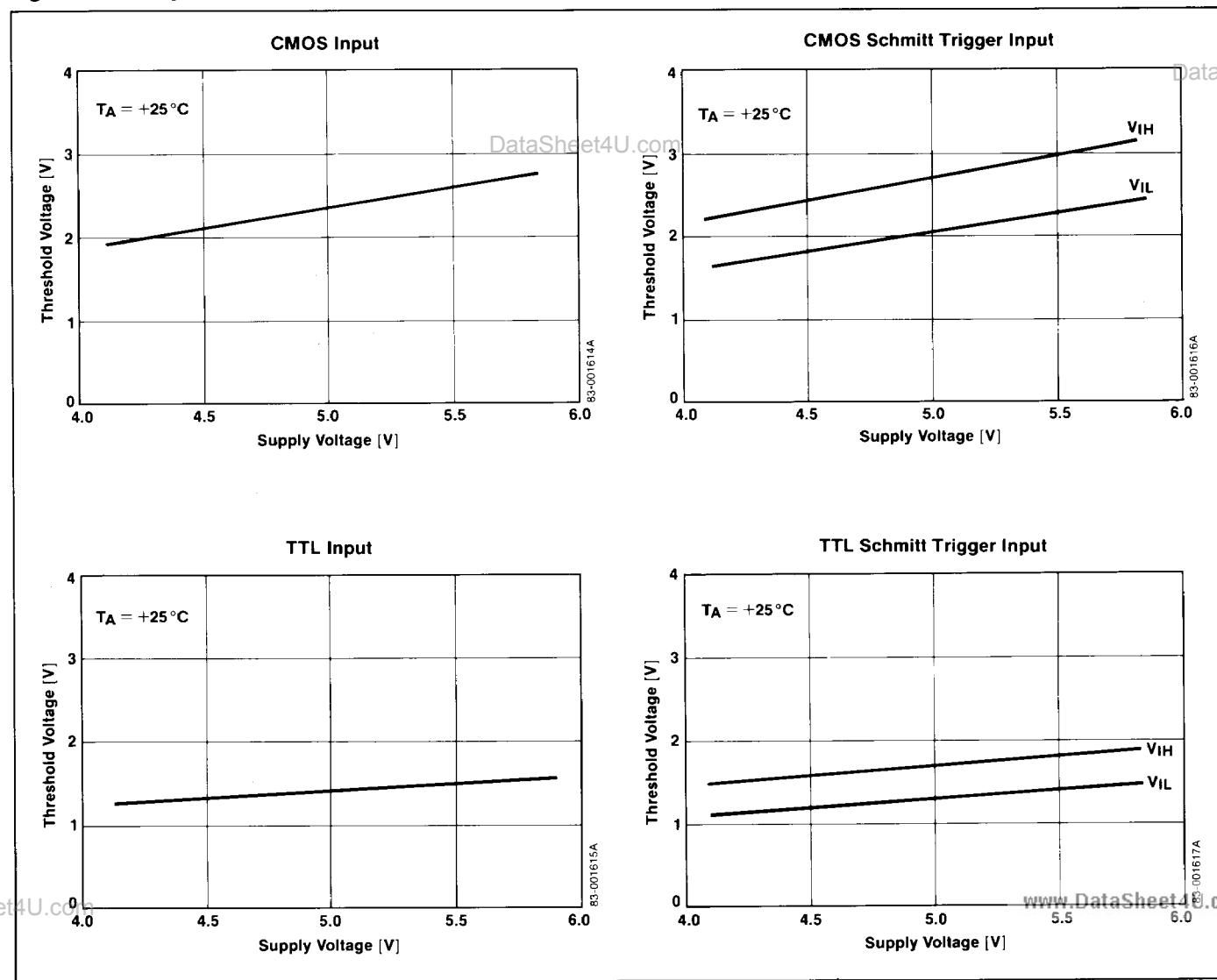
Table 5-2. Recommended Operating Conditions

Parameter	Symbol	CMOS Level		TTL Level		Unit
		Min	Max	Min	Max	
Power supply voltage	V_{DD}	4.5	5.5	4.75	5.25	V
Ambient temperature	T_A	−40	+85	0	+70	°C
Low-level input voltage	V_{IL}	0	0.3 V_{DD}	0	0.8	V
High-level input voltage	V_{IH}	0.7 V_{DD}	V_{DD}	2.0	V_{DD}	V
Input rise or fall time (1)	t_R, t_F	0	10	0	10	μs
Positive Schmitt trigger voltage (2)	V_P	1.8	4.0	1.2	2.3	V
Negative Schmitt trigger voltage (2)	V_N	0.6	3.1	0.6	1.8	V
Hysteresis voltage (2)	V_H	0.3	1.5	0.3	1.5	V

Note:

(1) For Schmitt trigger input buffers.

(2) $V_{DD} = 5.0$ V

Figure 5-1. Input Buffers; Output Voltage vs Input Voltage**Figure 5-2. Input Buffers; Threshold Voltage vs Supply Voltage**

1.5-Micron CMOS-4 and -4A

Figure 5-3. Input Buffers; Threshold Voltage vs Ambient Temperature

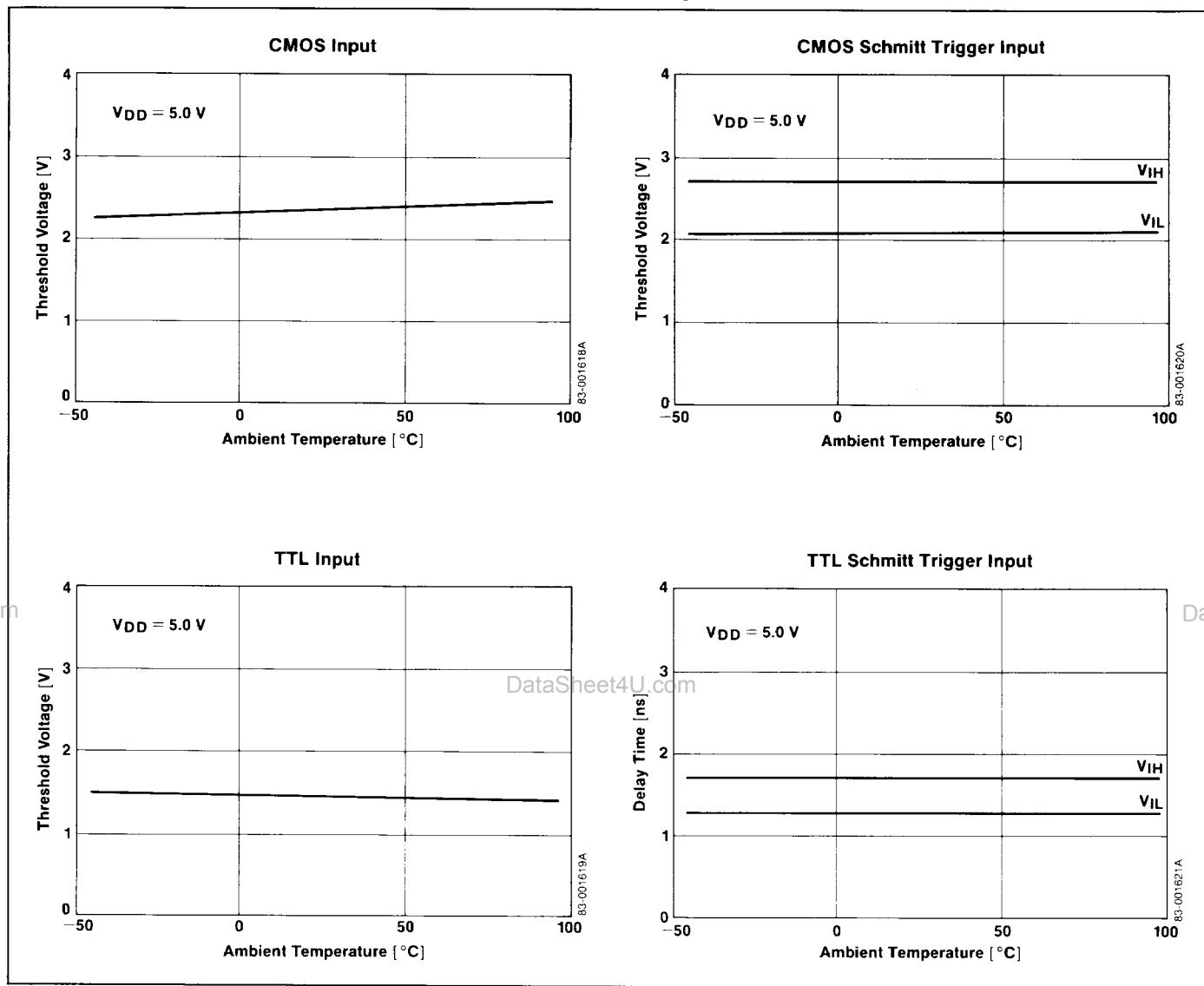
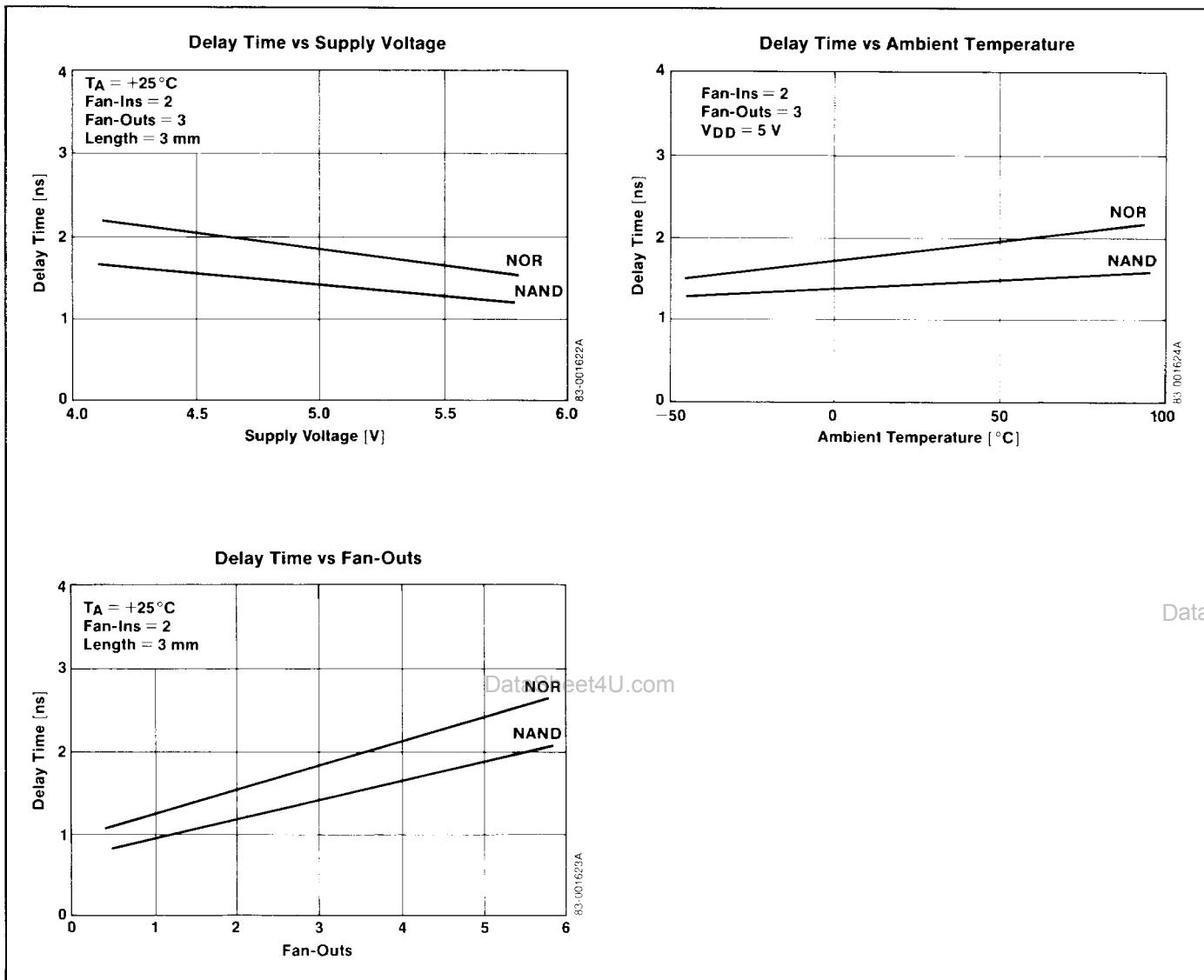


Figure 5-4. Internal Gate Delay Time

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Figure 5-5. Output Buffers (FO01); Output Current vs Output Voltage

